











LMH6702-MIL

SNOSD58 - JUNE 2017

# LMH6702-MIL 1.7-GHz Ultra-Low Distortion Wideband Op Amp

#### Features

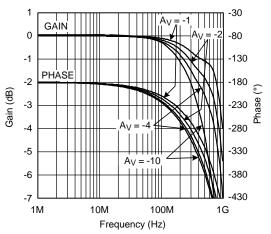
 $V_S = \pm 5 \text{ V}, T_A = 25^{\circ}\text{C}, A_V = 2\text{V/V}, R_L = 100 \Omega,$ V<sub>OUT</sub> = 2 V<sub>PP</sub>, Typical Unless Noted:

- 2<sup>nd</sup> and 3<sup>rd</sup> Harmonics (5 MHz, SOT-23) -100/-96
- -3-dB Bandwidth ( $V_{OUT} = 0.5 V_{PP}$ ) 1.7 GHz
- Low Noise 1.83 nV/√Hz
- Fast Settling to 0.1% 13.4 ns
- Fast Slew Rate 3100 V/µs
- Supply Current 12.5 mA
- Output Current 80 mA
- Low Intermodulation Distortion (75 MHz) -67 dBc
- Improved Replacement for CLC409 and CLC449

# **Applications**

- Flash A-D Driver
- D-A Transimpedance Buffer
- Wide Dynamic Range IF Amp
- Radar and Communication Receivers
- Line Driver
- High Resolution Video

# **Inverting Frequency Response**



# 3 Description

The LMH6702-MIL is a very wideband, DC-coupled monolithic operational amplifier designed specifically for wide dynamic range systems requiring exceptional signal fidelity. Benefitting from current feedback architecture, the LMH6702-MIL offers unity gain stability at exceptional speed without need for external compensation.

With its 720-MHz bandwidth ( $A_V = 2 \text{ V/V}$ ,  $V_O = 2 \text{ V}_{PP}$ ), 10-bit distortion levels through 60-MHz ( $R_1 = 100 \Omega$ ), 1.83-nV/\(\overline{Hz}\) input referred noise and 12.5-mA supply current, the LMH6702-MIL is the ideal driver or buffer for high-speed flash A-D and D-A converters.

Wide dynamic range systems such as radar and communication receivers that require a wideband amplifier offering exceptional signal purity will find the low input referred noise and low harmonic and intermodulation distortion of the LMH6702-MIL an attractive high speed solution.

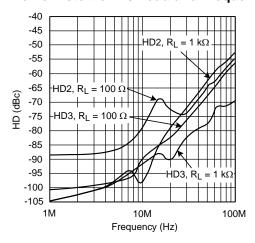
The LMH6702-MIL is constructed using VIP10™ complimentary bipolar process and proven current feedback architecture. The LMH6702-MIL is available in SOIC and SOT-23 packages.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)		
LMUCZO2 MII	SOIC (8)	4.90 mm × 3.91 mm		
LMH6702-MIL	SOT-23 (5)	2.90 mm × 1.60 mm		

(1) For all available packages, see the orderable addendum at the end of the datasheet.

#### Harmonic Distortion vs Load and Frequency







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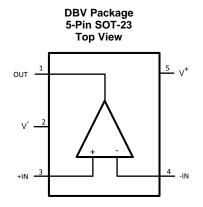
# 4 Revision History

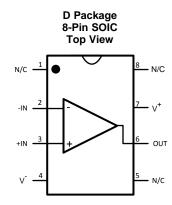
DATE	REVISION	NOTES
June 2017	*	Initial release.



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# **5 Pin Configuration and Functions**





NC: No internal connection

### **Pin Functions**

	PIN           NAME         NUMBER           D         DBV		PIN			
NAME			NUMBER		I/O	DESCRIPTION
NAIVIE						
-IN	2	4	I	Inverting input voltage		
+IN	3	3	I	Non-inverting input voltage		
N/C	1, 5, 8	_	-	No connection		
OUT	6	1	0	Output		
V-	4	2	I	Negative supply		
V+	7	5	I	Positive supply		

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# 6 Specifications

# 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)(2)

		MIN	MAX	UNIT
$V_S$			±6.75	V
I <sub>OUT</sub>			See <sup>(3)</sup>	
Common mode input voltage			V <sup>-</sup> to V <sup>+</sup>	V
Maximum junction temperature			150	°C
Storage temperature		-65	150	°C
Caldarina information	Infrared or convection (20 s)		235	°C
Soldering information	Wave soldering (10 s)		260	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 6.2 ESD Ratings

			VALUE	UNIT
.,		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2000	
V(ESD)	V <sub>(ESD)</sub> Electrostatic discharge	Machine Model (MM), per JEDEC specification JESD22-C101, all pins (2)	±200	V

<sup>(1)</sup> Human body model: 1.5 kΩ in series with 100 pF. JEDEC document JEP155 states that 2000-V HBM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 2000-V HBM is possible with the necessary precautions. Pins listed as ±2000 V may actually have higher performance.

# 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

	MIN	MAX	UNIT
Operating temperature	-40	85	°C
Nominal supply voltage	±4	±6	V

<sup>(1)</sup> Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is intended to be functional, but specific performance is not ensured. For ensured specifications, see the Electrical Characteristics tables.

## 6.4 Thermal Information

		LMH670					
	THERMAL METRIC <sup>(1)</sup>	THERMAL METRIC <sup>(1)</sup> DBV (SOT-23) D (SO					
		5 PINS	8 PINS				
$R_{\theta JA}$	Junction-to-ambient thermal resistance	182	133	°C/W			
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	139	79	°C/W			
$R_{\theta JB}$	Junction-to-board thermal resistance	40	73	°C/W			
ΨЈТ	Junction-to-top characterization parameter	28	28	°C/W			
ΨЈВ	Junction-to-board characterization parameter	40	73	°C/W			

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report (SPRA953).

Product Folder Links: LMH6702-MIL

<sup>2)</sup> If Military/Aerospace specified devices are required, please contact the TI Sales Office/ Distributors for availability and specifications.

<sup>(3)</sup> The maximum output current (I<sub>OUT</sub>) is determined by device power dissipation limitations.

<sup>(2)</sup> Machine model: 0 Ω in series with 200 pF. JEDEC document JEP157 states that 200-V MM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 200-V MM is possible with the necessary precautions. Pins listed as ±200 V may actually have higher performance.



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# 6.5 Electrical Characteristics

at  $A_V = 2$ ,  $V_S = \pm 5$  V,  $R_I = 100$   $\Omega$ ,  $R_F = 237$   $\Omega$  (unless otherwise noted)<sup>(1)</sup>

	PARAMETER	TEST CONDITIONS	MIN <sup>(2)</sup> TYP <sup>(3)</sup> MAX <sup>(2)</sup>	UNIT
FREQUE	NCY DOMAIN PERFORMANO	CE	'	
SSBW <sub>SM</sub>		$V_{OUT} = 0.5 V_{PP}$	1700	
SSBW <sub>LG</sub>	<u> </u>	V <sub>OUT</sub> = 2 V <sub>PP</sub>	720	
LSBW <sub>LG</sub>	-3-dB Bandwidth	V <sub>OUT</sub> = 4 V <sub>PP</sub>	480	MHz
SSBW <sub>HG</sub>	=	$V_{OUT} = 2 V_{PP}, A_V = +10$	140	
GF <sub>0.1dB</sub>	0.1-dB gain flatness	V <sub>OUT</sub> = 2 V <sub>PP</sub>	120	MHz
LPD	Linear phase deviation	DC to 100 MHz	0.09	deg
		R <sub>1</sub> =150 Ω, 3.58 MHz	0.024%	
DG	Differential gain	R <sub>L</sub> =150 Ω, 4.43 MHz	0.021%	
		$R_L = 150 \Omega$ , 3.58 MHz	0.004	
DP	Differential phase	R <sub>L</sub> = 150 Ω, 4.43 MHz	0.007	deg
TIME DO	MAIN RESPONSE	142 - 100 12, 1.10 10112	0.001	
Time Doi	MAIN REGI ONCE	2-V Step, TRS	0.87	
t <sub>R</sub>	Rise time	2-V Step, TRL	0.77	ns
		6-V Step, TRS	1.70	
$t_{\text{F}}$	Fall time	6-V Step, TRL	1.70	ns
os	Overshoot	2-V Step	0%	
SR	Overshoot	6 V <sub>PP</sub> , 40% to 60% <sup>(4)</sup>		1////
	Slew rate		3100	V/µs
T <sub>s</sub>	Settling time to 0.1%	2-V Step	13.4	ns
DISTORT	ION AND NOISE RESPONSE	T	400	
HD2L		2 V <sub>PP</sub> , 5 MHz <sup>(5)</sup> (SOT-23)	-100	dBc
	-	2 V <sub>PP</sub> , 5 MHz <sup>(5)</sup> (SOIC)	-87	
HD2	2 <sup>nd</sup> Harmonic distortion	2V <sub>PP</sub> , 20 MHz <sup>(5)</sup> (SOT-23)	-79	dBc
	_	2V <sub>PP</sub> , 20 MHz <sup>(5)</sup> (SOIC)	-72	
HD2H		2V <sub>PP</sub> , 60 MHz <sup>(5)</sup> (SOT-23)	-63	dBc
		2V <sub>PP</sub> , 60 MHz <sup>(5)</sup> (SOIC)	-64	
HD3L		2V <sub>PP</sub> , 5 MHz <sup>(5)</sup> (SOT-23)	-96	dBc
	_	2V <sub>PP</sub> , 5 MHz <sup>(5)</sup> (SOIC)	-98	
HD3	3 <sup>rd</sup> Harmonic distortion	2V <sub>PP</sub> , 20 MHz <sup>(5)</sup> (SOT-23)	-88	dBc
1100	o Harmonio distortion	2V <sub>PP</sub> , 20 MHz <sup>(5)</sup> (SOIC)	-82	аво
HD3H		2V <sub>PP</sub> , 60 MHz <sup>(5)</sup> (SOT-23)	-70	dBc
TIDOTT		2V <sub>PP</sub> , 60 MHz <sup>(5)</sup> (SOIC)	-65	abc
OIM3	IMD	75 MHz, P <sub>O</sub> = 10dBm/ tone	<b>-67</b>	dBc
$V_N$	Input referred voltage noise	>1 MHz	1.83	nV/√ <del>Hz</del>
I <sub>N</sub>	Input referred inverting noise current	>1 MHz	18.5	pA/√Hz
I <sub>NN</sub>	Input referred non-inverting noise current	>1 MHz	3.0	pA/√Hz
SNF	Total input noise floor	>1 MHz	-158	dBm <sub>1Hz</sub>
INV	Total integrated input noise	1 MHz to 150 MHz	35	μV

<sup>(1)</sup> Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that  $T_J = T_A$ . No guarantee of parametric performance is indicated in the electrical tables under conditions of internal self-heating where  $T_J > T_A$ . Min/Max ratings are based on production testing unless otherwise specified.

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All limits are ensured by testing or statistical analysis. Typical numbers are the most likely parametric norm.

Slew Rate is the average of the rising and falling edges.

Harmonic distortion is strongly influenced by package type (SOT-23 or SOIC). See Application Note section under Harmonic Distortion for more information.



# **Electrical Characteristics (continued)**

at  $A_V$  = 2,  $V_S$  = ±5 V,  $R_L$  = 100  $\Omega$ ,  $R_F$  = 237  $\Omega$  (unless otherwise noted)<sup>(1)</sup>

PARAMETER		TEST	MIN <sup>(2)</sup>	TYP <sup>(3)</sup>	MAX <sup>(2)</sup>	UNIT	
STATIC,	DC PERFORMANCE						
1/	Innut offeet voltege				±1.0	±4.5	mV
$V_{IO}$	Input offset voltage		$-40 \le T_J \le 85$			±6.0	IIIV
DV <sub>IO</sub>	Input offset voltage average drift	See <sup>(6)</sup>			-13		μV/°C
	Input bigg ourrent	Non-Inverting <sup>(7)</sup>			-6	-15	
I <sub>BN</sub>	Input bias current	Non-inverting V	$-40 \le T_J \le 85$			-21	μA
$DI_BN$	Input bias current average drift	Non-Inverting <sup>(6)</sup>			+40		nA/°C
	Innut biog gurrant	Inverting <sup>(7)</sup>			-8	±30	
I <sub>BI</sub>	Input bias current	inverting (*)	-40 ≤ T <sub>J</sub> ≤ 85			±34	μA
DI <sub>BI</sub>	Input bias current average drift	Inverting <sup>(6)</sup>			-10		nA/°C
DCDD Dower cumple	Davies aventure is etien netic	DC.		47	52	52	
PSRR	Power supply rejection ratio	DC	$-40 \le T_J \le 85$	45			dB
CMDD	Common mode rejection	DC		45	48		٩D
CMRR	ration	DC	$-40 \le T_J \le 85$	44			dB
	0 1	D		11.0	12.5	16.1	0
I <sub>CC</sub>	Supply current	R <sub>L</sub> = ∞	-40 ≤ T <sub>J</sub> ≤ 85	10.0		17.5	mA
MISCEL	LANEOUS PERFORMANCE						
R <sub>IN</sub>	Input resistance	Non-Inverting			1.4		МΩ
C <sub>IN</sub>	Input capacitance	Non-Inverting			1.6		pF
R <sub>OUT</sub>	Output resistance	Closed Loop			30		mΩ
\ <u></u>	Output voltage renge	P = 100 O		±3.3	±3.5		V
V <sub>OL</sub>	Output voltage range	$R_L = 100 \Omega$	-40 ≤ T <sub>J</sub> ≤ 85	±3.2			v
CMIR	Input voltage range	Common Mode		±1.9	±2.2		V
Io	Output current			50	80		mA

<sup>(6)</sup> Drift determined by dividing the change in parameter at temperature extremes by the total temperature change.(7) Negative input current implies current flowing out of the device.

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# 6.6 Typical Characteristics

 $T_A = 25$ °C,  $V_S = \pm 5$  V,  $R_L = 100$   $\Omega$ ,  $R_f = 237$   $\Omega$  (unless otherwise noted)

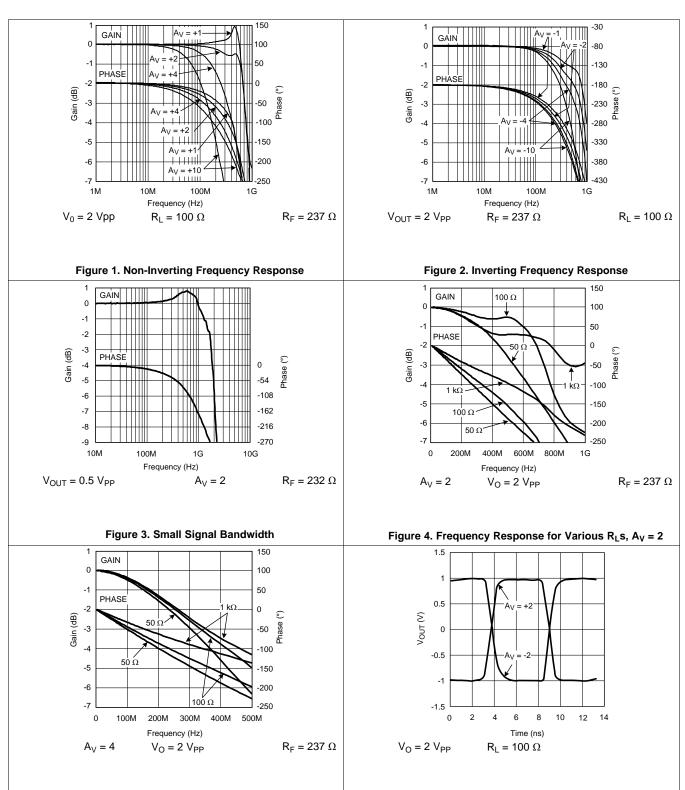


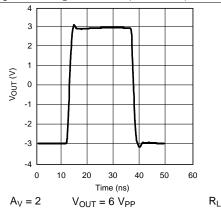
Figure 5. Frequency Response for Various  $R_L$ s,  $A_V = 4$ 

Figure 6. Step Response, 2 V<sub>PP</sub>

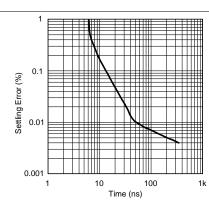
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# **Typical Characteristics (continued)**

 $T_A = 25$ °C,  $V_S = \pm 5$  V,  $R_L = 100$   $\Omega$ ,  $R_f = 237$   $\Omega$  (unless otherwise noted)

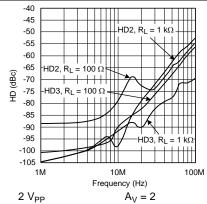






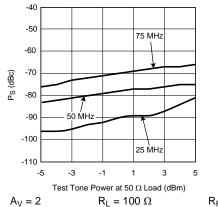
 $R_L = 100 \Omega$ 

Figure 7. Step Response, 6 V<sub>PP</sub>



 $R_F = 237 \Omega$ 

Figure 8. Percent Settling vs Time



 $R_L = 100 \Omega$  $R_F = 237 \Omega$ 

Figure 9. Harmonic Distortion vs Load and Frequency (SOIC Package)

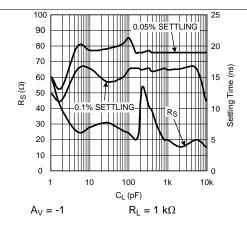


Figure 11. R<sub>S</sub> and Settling Time vs C<sub>L</sub>

Figure 10. 2 Tone 3rd Order Spurious Level (SOIC Package)

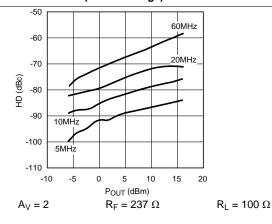


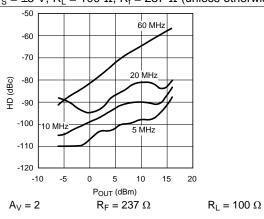
Figure 12. HD2 vs Output Power (Across 100  $\Omega$ ) (SOIC Package)



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**Typical Characteristics (continued)** 

 $T_A = 25$ °C,  $V_S = \pm 5$  V,  $R_L = 100$   $\Omega$ ,  $R_f = 237$   $\Omega$  (unless otherwise noted)



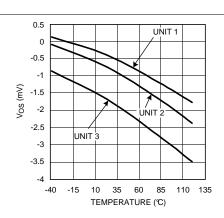
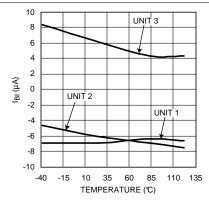


Figure 13. HD3 vs Output Power (Across 100  $\Omega$ ) (SOIC Package)

Figure 14. Input Offset for 3 Representative Units



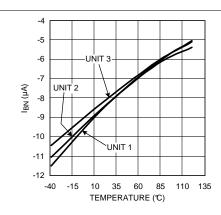
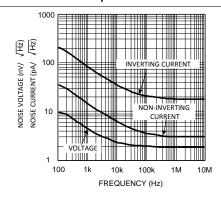


Figure 15. Inverting Input Bias for 3 Representative Units

Figure 16. Non-Inverting Input Bias for 3 Representative Units



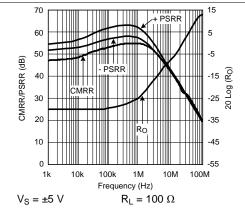


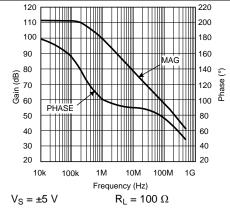
Figure 17. Noise

Figure 18. CMRR, PSRR,  $R_{\rm OUT}$ 

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# **Typical Characteristics (continued)**

 $T_A$  = 25°C,  $V_S$  = ±5 V,  $R_L$  = 100  $\Omega$ ,  $R_f$  = 237  $\Omega$  (unless otherwise noted)



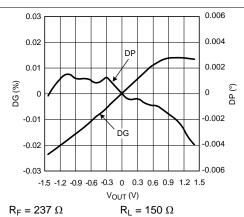


Figure 19. Transimpedance

Figure 20. DG/DP (NTSC)

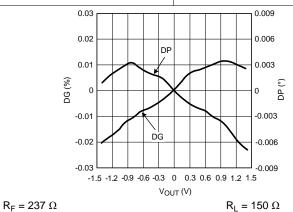


Figure 21. DG/DP (PAL)

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# 7 Detailed Description

#### 7.1 Overview

The LMH6702-MIL has been optimized for exceptionally low harmonic distortion while driving very demanding resistive or capacitive loads. Generally, when used as the input amplifier to very high speed flash ADCs, the distortions introduced by the converter will dominate over the low LMH6702-MIL distortions shown in *Typical Characteristics*.

### 7.2 Feature Description

#### 7.2.1 Harmonic Distortion

The capacitor  $C_{SS}$ , shown across the supplies in Figure 24 and Figure 25, is critical to achieving the lowest  $2^{nd}$  harmonic distortion. For absolute minimum distortion levels, it is also advisable to keep the supply decoupling currents (ground connections to  $C_{POS}$ , and  $C_{NEG}$  in Figure 24 and Figure 25) separate from the ground connections to sensitive input circuitry (such as  $R_G$ ,  $R_T$ , and  $R_{IN}$  ground connections). Splitting the ground plane in this fashion and separately routing the high frequency current spikes on the decoupling caps back to the power supply (similar to *Star Connection* layout technique) ensures minimum coupling back to the input circuitry and results in best harmonic distortion response (especially  $2^{nd}$  order distortion).

If this layout technique has not been observed on a particular application board, designer may actually find that supply decoupling caps could adversely affect HD2 performance by increasing the coupling phenomenon already mentioned. Figure 22 shows actual HD2 data on a board where the ground plane is *shared* between the supply decoupling capacitors and the rest of the circuit. Once these capacitors are removed, the HD2 distortion levels reduce significantly, especially between 10 MHz to 20 MHz, as shown in Figure 22:

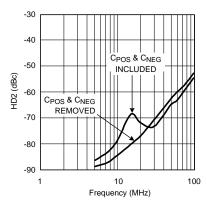


Figure 22. Decoupling Current Adverse Effect on a Board with Shared Ground Plane

At these extremely low distortion levels, the high frequency behavior of decoupling capacitors themselves could be significant. In general, lower value decoupling caps tend to have higher resonance frequencies making them more effective for higher frequency regions. A particular application board which has been laid out correctly with ground returns *split* to minimize coupling, would benefit the most by having low value and higher value capacitors paralleled to take advantage of the effective bandwidth of each and extend low distortion frequency range.

Another important variable in getting the highest fidelity signal from the LMH6702-MIL is the package itself. As already noted, coupling between high frequency current transients on supply lines and the device input can lead to excess harmonic distortion. An important source of this coupling is in fact through the device bonding wires. A smaller package, in general, will have shorter bonding wires and therefore lower coupling. This is true in the case of the SOT-23 compared to the SOIC package where a marked improvement in HD can be measured in the SOT-23 package. Figure 23 shows the HD comparing SOT-23 to SOIC package:

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# **Feature Description (continued)**

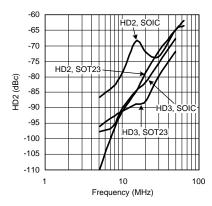


Figure 23. SOIC and SOT-23 Packages Distortion Terms Compared

The LMH6702-MIL data sheet shows both SOT-23 and SOIC data in *Electrical Characteristics* to aid in selecting the right package. *Typical Characteristics* shows SOIC package plots only.

#### 7.3 Device Functional Modes

# 7.3.1 2-Tone 3<sup>rd</sup> Order Intermodulation

Figure 10 shows a relatively constant difference between the test power level and the spurious level with the difference depending on frequency. The LMH6702-MIL does not show an intercept type performance, (where the relative spurious levels change at a 2X rate versus the test tone powers), due to an internal full power bandwidth enhancement circuit that boosts the performance as the output swing increases while dissipating negligible quiescent power under low output power conditions. This feature enhances the distortion performance and full power bandwidth to match that of much higher quiescent supply current parts.

# 7.3.2 DC Accuracy and Noise

The example in Equation 1 shows the output offset computation equation for the non-inverting configuration using the typical bias current and offset specifications for  $A_{V} = 2$ :

Output Offset:

$$V_O = (\pm I_{BN} \cdot R_{IN} \pm V_{IO}) (1 + R_F/R_G) \pm I_{BI} \cdot R_F$$

where

R<sub>IN</sub> is the equivalent input impedance on the non-inverting input.

Example computation for  $A_V = +2$ ,  $R_F = 237\Omega$ ,  $R_{IN} = 25\Omega$ :

$$V_O = (\pm 6 \mu A \times 25 \Omega \pm 1 mV) (1 + 237/237) \pm 8 \mu A \times 237 = \pm 4.20 mV$$
 (2)

A good design, however, should include a worst case calculation using min/max numbers in the data sheet tables, in order to ensure *worst case* operation.

Further improvement in the output offset voltage and drift is possible using the composite amplifiers described in Application Note OA--07, *Current Feedback Op Amp Applications Circuit Guide* (SNOA365). The two input bias currents are physically unrelated in both magnitude and polarity for the current feedback topology. It is not possible, therefore, to cancel their effects by matching the source impedance for the two inputs (as is commonly done for matched input bias current devices).

The total output noise is computed in a similar fashion to the output offset voltage. Using the input noise voltage and the two input noise currents, the output noise is developed through the same gain equations for each term but combined as the square root of the sum of squared contributing elements. See Application Note OA-12, *Noise Analysis for Comlinear Amplifiers* (SNOA375) for a full discussion of noise calculations for current feedback amplifiers.

(1)



# 8 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

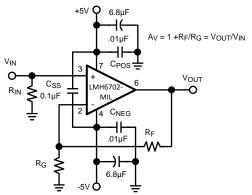
## 8.1 Application Information

The LMH6702-MIL achieves its excellent pulse and distortion performance by using the current feedback topology. The loop gain for a current feedback op amp, and hence the frequency response, is predominantly set by the feedback resistor value. The LMH6702-MIL is optimized for use with a 237- $\Omega$  feedback resistor. Using lower values can lead to excessive ringing in the pulse response while a higher value will limit the bandwidth.

### 8.2 Typical Application

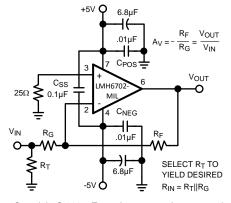
#### 8.2.1 Feedback Resistor

The LMH6702-MIL achieves its excellent pulse and distortion performance by using the current feedback topology. The loop gain for a current feedback op amp, and hence the frequency response, is predominantly set by the feedback resistor value. The LMH6702-MIL is optimized for use with a  $237-\Omega$  feedback resistor. Using lower values can lead to excessive ringing in the pulse response while a higher value will limit the bandwidth.



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Figure 24. Recommended Non-Inverting Gain Circuit



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Figure 25. Recommended Inverting Gain Circuit

Product Folder Links: LMH6702-MIL

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# **Typical Application (continued)**

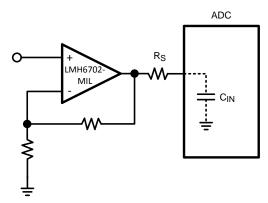
#### 8.2.2 Design Requirements

The exceptional performance and uniquely targeted superior technical specifications of the LMH6702-MIL make it a natural choice for high speed data acquisition applications as a front end amplifier driving the input of a high performance ADC. Of these specifications, the following can be discussed in more detail:

- 1. A bandwidth of 1.7 GHz and relative insensitivity of bandwidth to closed loop gain (characteristic of Current Feedback architecture when compared to the traditional voltage feedback architecture) as shown in Figure 1.
- 2. Ultra-low distortion approaching -87 dBc at the lower frequencies and exceptional noise performance (see Figure 9 and Figure 17).
- 3. Fast settling in less than 20 ns (see Figure 27).

As the input of an ADC could be capacitive in nature and could also alternate in capacitance value during a typical acquisition cycle, the driver amplifier (LMH6702-MIL in this case) should be designed so that it avoids instability, peaking, or other undesirable artifacts.

For Capacitive Load Drive, see Figure 26, which shows a typical application using the LMH6702-MIL to drive an ADC.



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Figure 26. Input Amplifier to ADC

#### 8.2.3 Detailed Design Procedure

The series resistor,  $R_S$ , between the amplifier output and the ADC input is critical to achieving best system performance. This load capacitance, if applied directly to the output pin, can quickly lead to unacceptable levels of ringing in the pulse response. Figure 27 in *Application Curve* ( $R_S$  and Settling Time vs  $C_L$ ) is an excellent starting point for selecting  $R_S$ . The value derived in that plot minimizes the step settling time into a fixed discrete capacitive load with the output driving a very light resistive load (1 k $\Omega$ ). Sensitivity to capacitive loading is greatly reduced once the output is loaded more heavily. Therefore, for cases where the output is heavily loaded,  $R_S$  value may be reduced. The exact value may best be determined experimentally for these cases.

In applications where the LMH6702-MIL is replacing the CLC409, care must be taken when the device is lightly loaded and some capacitance is present at the output. Due to the much higher frequency response of the LMH6702-MIL compared to the CLC409, there could be increased susceptibility to low value output capacitance (parasitic or inherent to the board layout or otherwise being part of the output load). As already mentioned, this susceptibility is most noticeable when the LMH6702-MIL's resistive load is light. Parasitic capacitance can be minimized by careful lay out. Addition of an output snubber R-C network will also help by increasing the high frequency resistive loading.

Referring back to Figure 26, it must be noted that several additional constraints should be considered in driving the capacitive input of an ADC. There is an option to increase  $R_{\rm S}$ , band-limiting at the ADC input for either noise or Nyquist band-limiting purposes. However, increasing  $R_{\rm S}$  too much can induce an unacceptably large input glitch due to switching transients coupling through from the *convert* signal. Also,  $C_{\rm IN}$  is oftentimes a voltage dependent capacitance. This input impedance non-linearity will induce distortion terms that will increase as  $R_{\rm S}$  is increased. Only slight adjustments up or down from the recommended  $R_{\rm S}$  value should therefore be attempted in optimizing system performance.

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# Typical Application (continued)

#### 8.2.4 Application Curve

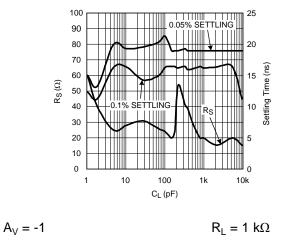


Figure 27. R<sub>S</sub> and Settling Time vs C<sub>L</sub>

# 9 Power Supply Recommendations

The LMH6702-MIL can operate off a single supply or with dual supplies as long as the input CM voltage range (CMIR) has the required headroom to either supply rail. Supplies should be decoupled with low inductance, often ceramic, capacitors to ground less than 0.5 inches from the device pins. The use of ground plane is recommended, and as in most high speed devices, it is advisable to remove ground plane close to device sensitive pins such as the inputs.

# 10 Layout

# 10.1 Layout Guidelines

Generally, a good high frequency layout will keep power supply and ground traces away from the inverting input and output pins. Parasitic capacitances on these nodes to ground will cause frequency response peaking and possible circuit oscillations. See *Frequent Faux Pas in Applying Wideband Current Feedback Amplifiers*, Application Note OA-15 (SNOA367). Texas Instruments suggests the following evaluation boards as a guide for high frequency layout and as an aid in device testing and characterization. See Table 1 for details.

The LMH6702-MIL evaluation board(s) is a good example of high frequency layout techniques as a reference. General high-speed, signal-path layout suggestions include:

- Continuous ground planes are preferred for signal routing with matched impedance traces for longer runs.
  However, open up both ground and power planes around the capacitive sensitive input and output device
  pins as shown in Figure 28. After the signal is sent into a resistor, parasitic capacitance becomes more of a
  bandlimiting issue and less of a stability issue.
- Use good, high-frequency decoupling capacitors (0.1 μF) on the ground plane at the device power pins as shown in Figure 28. Higher value capacitors (2.2 μF) are required, but may be placed further from the device power pins and shared among devices. For best high-frequency decoupling, consider X2Y supply-decoupling capacitors that offer a much higher self-resonance frequency over standard capacitors.
- When using differential signal routing over any appreciable distance, use microstrip layout techniques with matched impedance traces.
- The input summing junction is very sensitive to parasitic capacitance. Connect any Rf, and Rg elements into
  the summing junction with minimal trace length to the device pin side of the resistor, as shown in Figure 29.
  The other side of these elements can have more trace length if needed to the source or to ground.

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# 10.2 Layout Example

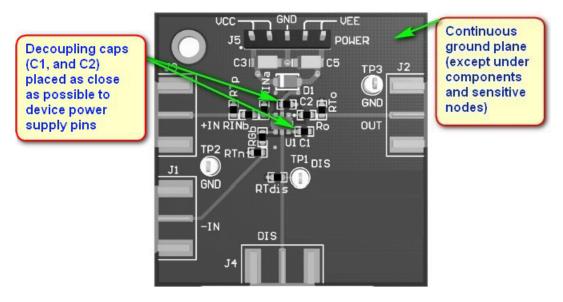


Figure 28. LMH6702-MIL Evaluation Board Layer 1

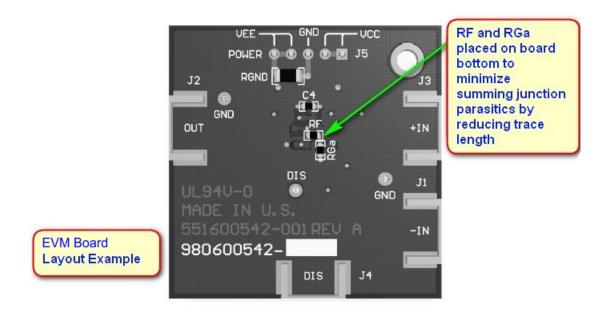


Figure 29. LMH6702-MIL Evaluation Board Layer 2

**Table 1. Evaluation Board Comparison** 

DEVICE	PACKAGE	EVALUATION BOARD PART NUMBER
LMH6702-MILMF	SOT-23	LMH730216
LMH6702-MILMA	SOIC	LMH730227

# 11 Device and Documentation Support

# 11.1 Documentation Support

#### 11.1.1 Related Documentation

For related documentation, see the following:

- Absolute Maximum Ratings for Soldering (SNOA549)
- Current Feedback Op Amp Applications Circuit Guide, Application Note OA--07 (SNOA365)
- Frequent Faux Pas in Applying Wideband Current Feedback Amplifiers, Application Note OA-15 (SNOA367)
- Noise Analysis for Comlinear Amplifiers, Application Note OA-12 (SNOA375)
- Semiconductor and IC Package Thermal Metrics (SPRA953)

#### 11.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community T's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support TI's Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 11.3 Trademarks

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# 11.4 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 11.5 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

# 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
LMH6702 MDC	Active	Production	DIESALE (Y)   0	754   NOT REQUIRED	Yes	Call TI	Level-1-NA-UNLIM	-40 to 85	
LMH6702-MDC.A	Active	Production	DIESALE (Y)   0	754   NOT REQUIRED	Yes	Call TI	Level-1-NA-UNLIM	-40 to 85	

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

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